

Notice of References Cited

Application/Control No.

09/908,992

Applicant(s)/Patent Under
Reexamination
SYKEN ET AL.

Examiner

Q. Janice Li

Art Unit

1632

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Han et al, Sequence ID AF244136, GenEmb1, 2000 April 30.
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